

**Search Notes**

Application/Control No.

10/676,961

Examiner

Chris C. Chu

Applicant(s)/Patent under  
Reexamination

PON ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	E25.031, E25.032 & E23.042	12/22/2005	C.C.
257	777 & 686	12/22/2005	C.C.
438	FOR368	12/22/2005	C.C.
438	FOR426	12/22/2005	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB;	12/22/2005	C.C.